


<b>Search Notes</b>  	<b>Application/Control No.</b>  10528839	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASHI ET AL.
	<b>Examiner</b>  Chu, Wutchung	<b>Art Unit</b>  2619

SEARCHED			
Class	Subclass	Date	Examiner
370	389, 412, 413, 415	1/5/2008	WC

SEARCH NOTES		
Search Notes	Date	Examiner
East search	1/5/2008	WC
Inventorship search	1/5/2008	WC
Manual search for class 370/389	1/5/2008	WC
Consulted with SPE Hassan Kizou	1/5/2008	WC
updated search	6/26/208	WC
consulted with SPE Edan Orgad	6/26/208	WC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner